Strip TEG

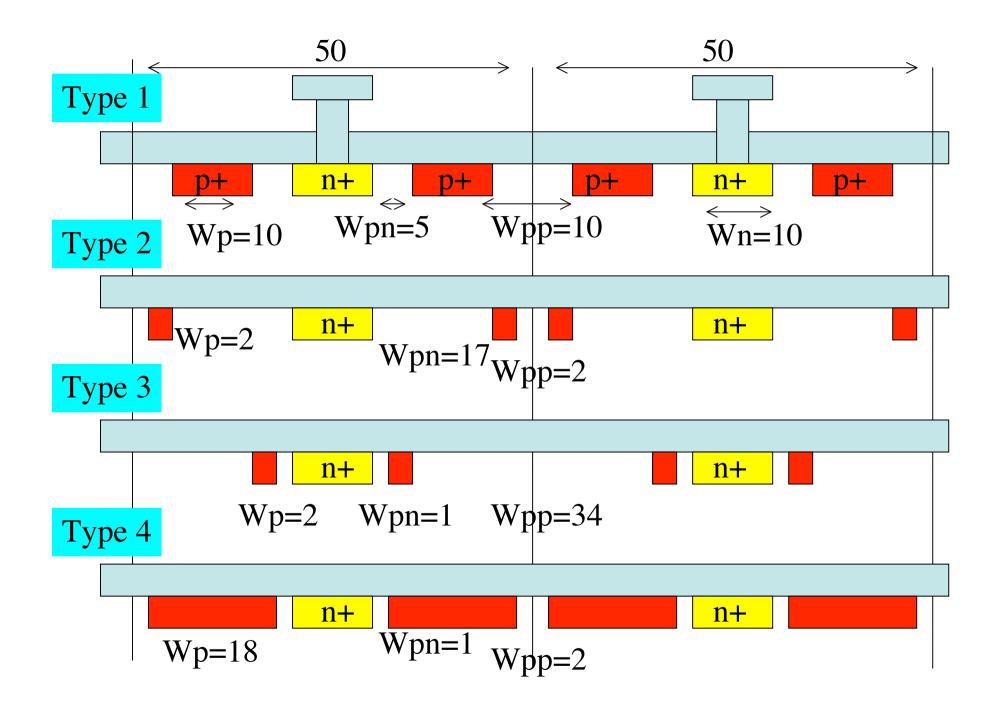
M. Hazumi and T. Tsuboyama 6 October 2005

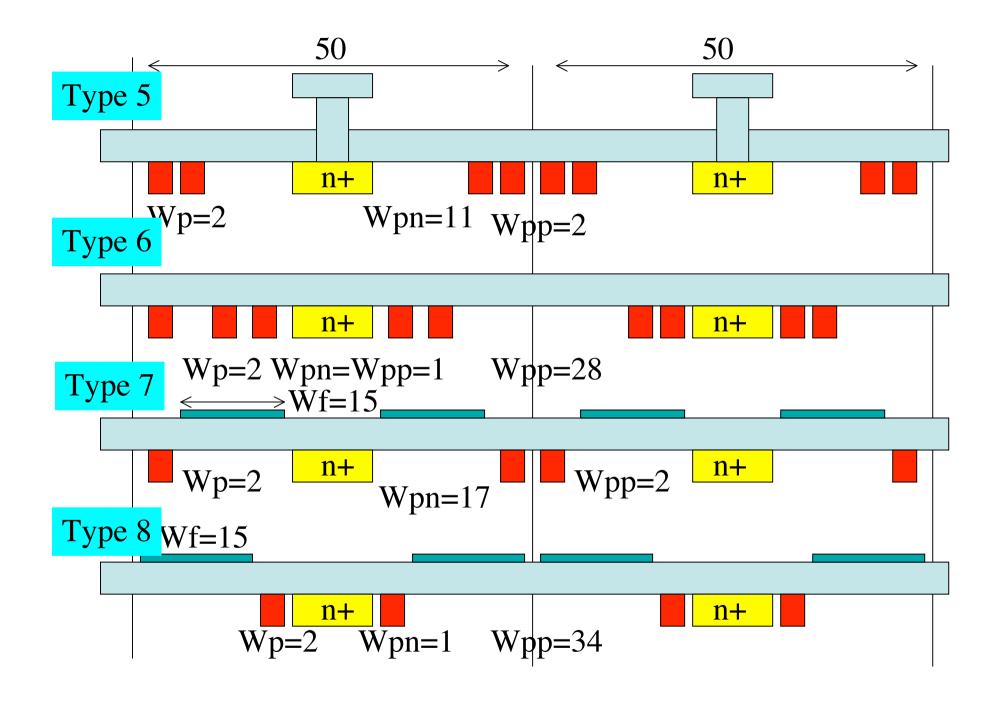
General design

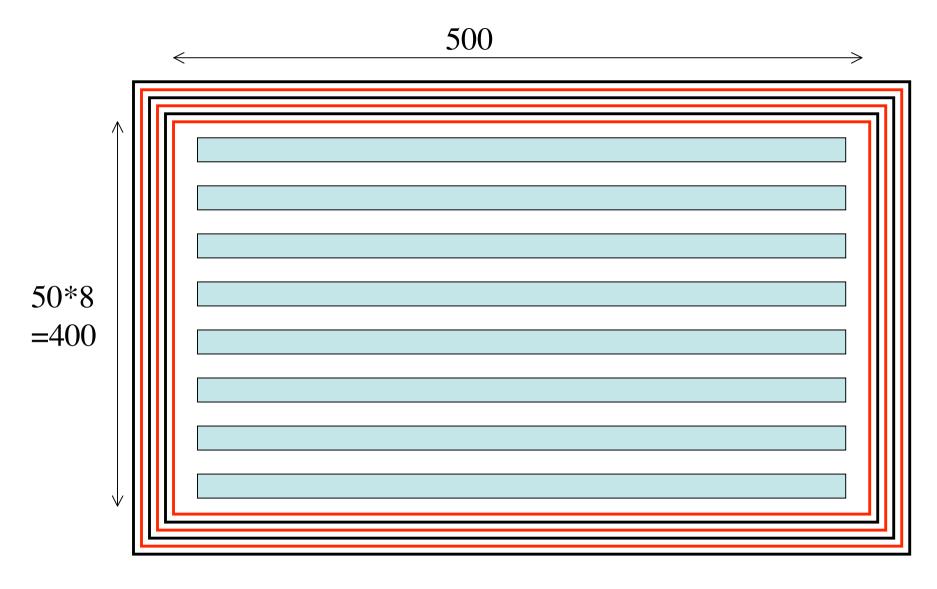
- Strip sensor:
 - Used for prove the validity of 2D simulation of TCAD.
 - Strip sensor is widely used for particle detector.
- DC type sensor. Why?
 - DC test is essential.
 - A few M Ohm poly-silicon resister is not practical.
 - Coupling capacitor (>10 pF) is not practical.
 - Simple structure.
- For evaluation as a prticle sensor, the chip will be bonded to APV25 readout chip.
 - Several RC chips, used for CLEO3 silicon vertex detector will be somehow obtained.

n-type strips on p-bulk.

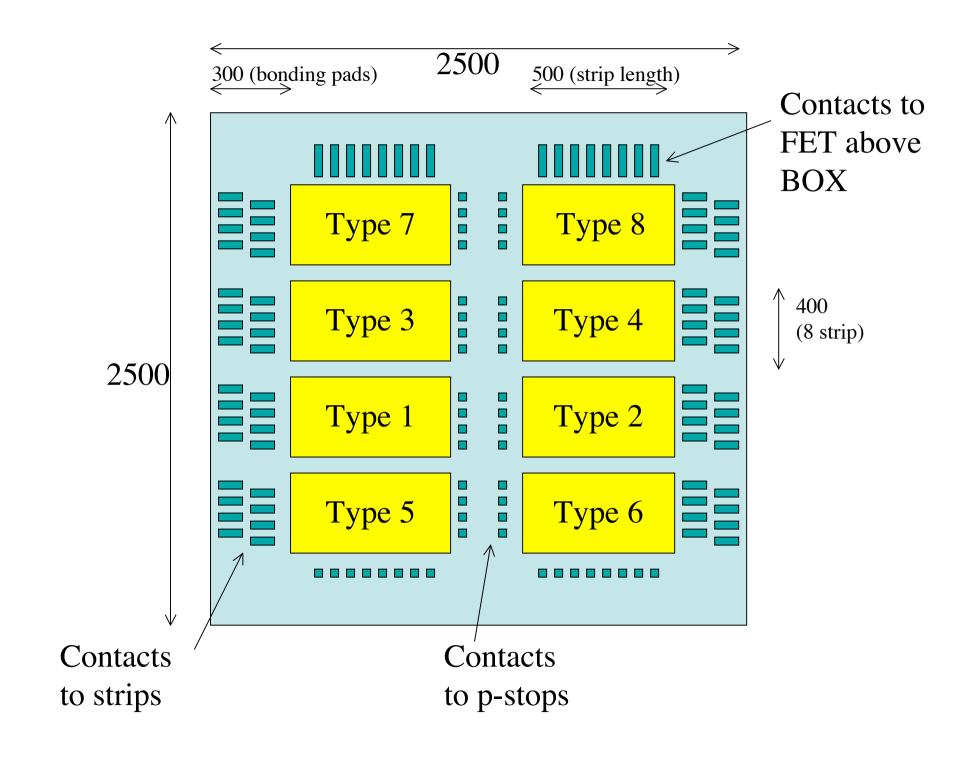
- p-stop is necessary to separate signal between strips.
- Shape of n-type implant is common (10um*460 um)





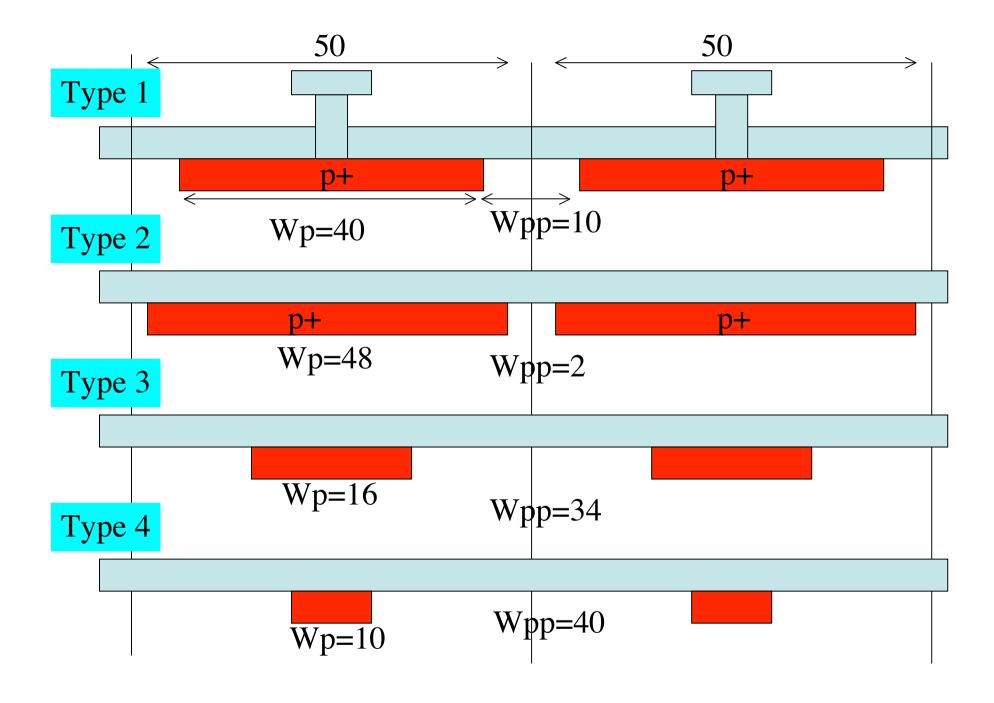


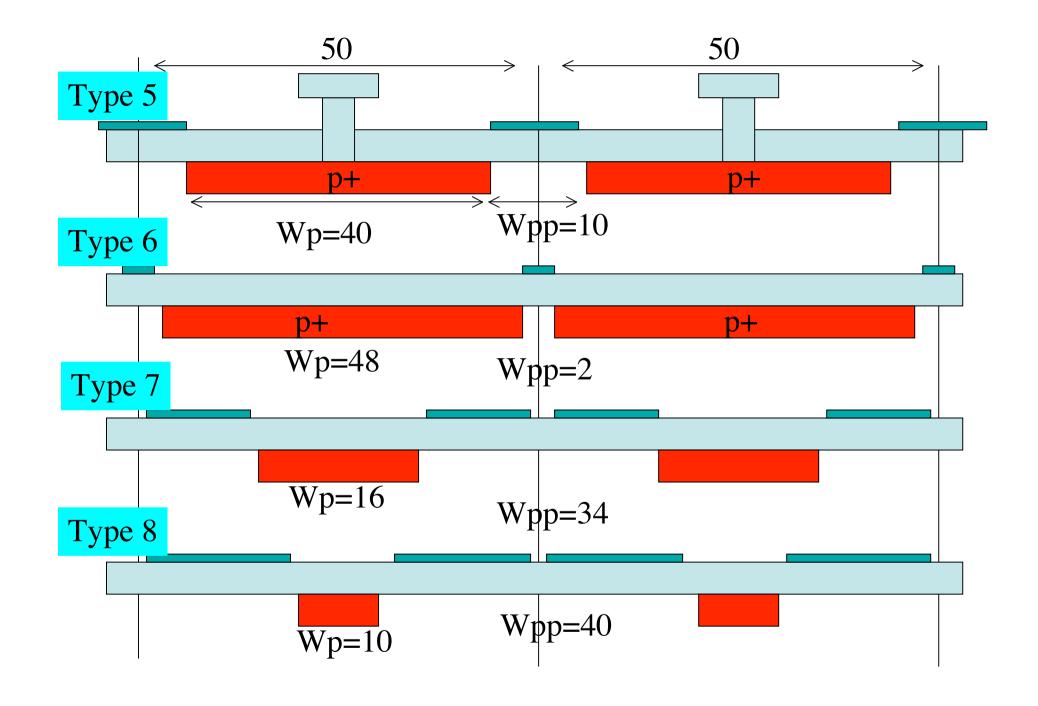
P-type guard ring
N-type guard ring

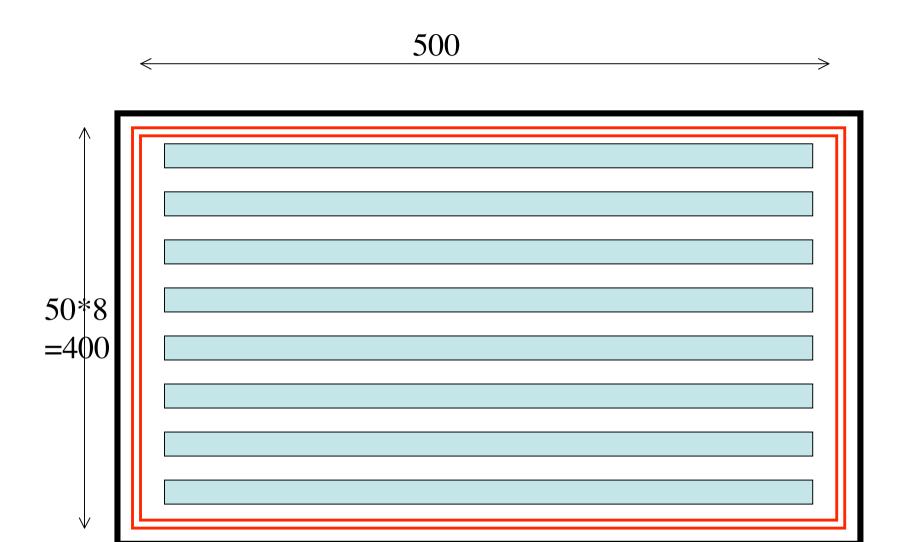


p-type strips on n-bulk.

- Separation is automatically established by p-n junction
- Type 1-4 simulate p-bulk strips.
- Type 5-8 are equipped with FET electrodes to control the interface charge.







Overall p-type guard ring N-type Bias ring

